

Substitute for form 1449/PTO				Complete If Known	
				Application Number	
				Filing Date	
				First Named Inventor	Quake, Stephen R., et. al.
				Art Unit	
				Examiner Name	
Page	1	of		Attorney Docket Number	020859-001310US

U.S. PATENT DOCUMENTS					
		Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
PL	AA	US-6,002,471	12/14/99	Quake	
	AB	US-			
	AC	US-			
	AD	US-			
	AE	US-			
	AF	US-			
	AG	US-			
	AH	US-			
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FOREIGN PATENT DOCUMENTS							
Examiner Initials*	Cite No. ¹	Foreign Patent Document		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶
		Country Code ³	Number ⁴				
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Examiner Signature	<i>Patricia L.</i>	Date Considered	1/18/2005
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NON PATENT LITERATURE DOCUMENTS				
Examiner Initials *	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.		
PL	BC	H. GERSEN et al., "Near-field effects in single molecule emission", Journal of Microscopy, Vol. 202, Pt 2, May 2001, pp. 374-378		T ²
PL	BD	H. GERSEN et al., "Influencing the Angular Emission of a Single Molecule", Physical Review Letters, Volume 85, Number 25, December 18, 2000, pp. 5312-5315		
PL	BE	J.M. GERTON et al., "Fluorescence Apertureless Near-field Optical Microscope for Biological Imaging", The 7th International Conference on Near-field Optics and Related Techniques, August 11-15, 2002, p. 71		
PL	BF	T.J. YANG et al., "An Apertureless Near-field Microscope for Fluorescence Imaging", Applied Physics Letters, Volume 76, Number 3, January 17, 2000, pp. 378-380		
PL	BG	GUILLAUME A. LESSARD et al., "A Scanning Apertureless Fluorescence Microscope", Department of Applied Physics, California Institute of Technology, Pasadena, California, pp. 1-8		
	BH			
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